

Notice of References Cited

Application/Control No.

10/523,994

Applicant(s)/Patent Under

Reexamination

TANAKA ET AL.

Examiner

Hoang Tran

Art Unit

2874

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0109650	06-2004	Kim et al.	385/100
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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